Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/616,700	HOWSE ET AL.
Examiner	Art Unit
Anthony Weier	1761

SEARCHED				
Class	Subclass	Date	Examiner	
426	656, 574	6/10/2006	AW	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

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	DATE	EXMR
Inventor Search	6/10/2006	AW
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